Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,892	HU ET AL.	
Examiner	Art Unit	
Anthony Weier	1761	

SEARCHED					
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Class	Subclass	Date	Examiner		
426	422, 423, 495, 592, 330.4	5/24/2006	AW		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

DATE 5/24/2006	EXMR
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